Application/Control No. Applicant(s)/Patent Under Reexamination 09/592,009 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tanh Q. Nguyen 2182 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,154,832 A	11-2000	Maupin, Patrick E.	712/228
*	В	US-6,975,613 B1	12-2005	Johansson, Per	370/338
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	7	US-			
	К	US-			
	١	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					7,0 3-0
	R					
L	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.